A cracked polymer templated metal network as a transparent conducting electrode for ITO-free organic solar cells†

K. D. M. Rao, Christoph Hunger, Ritu Gupta, Giridhar U. Kulkarni and Mukundan Thelakkat

We report a highly transparent, low resistance Ag metal network templated by a cracked polymer thin film and its incorporation in an organic solar cell. The performance of this scalable metallic network is comparable to that of conventional ITO electrodes. This is a general approach to replace ITO in diverse thin film devices.

Organic solar cells (OSCs) are an attractive option for large area and inexpensive production of modules. This is because OSCs are well suited to low cost manufacturing due to simple processing steps that are easily translated to roll-to-roll mass production and lead to near commercialization. In the recent past, extensive research has been carried out on the active semiconductor ingredients and electrode optimization in order to improve the OSC performance, which is typically poorer compared to other types of solar cells such as dye sensitized solar cells and silicon based solar cells. Nonetheless, OSCs occupy a unique position in the photovoltaic roadmap as solid state, flexible, environmentally benign and ultralight large area devices.

In OSCs, indium tin oxide (ITO) is the most commonly used transparent conducting electrode. Best ITO films exhibit a transmittance of 92% in the visible region and a sheet resistance of 10 ohm square. Indium is scarce and expensive; ITO requires high temperature processing, is brittle and develops cracks on flexible substrates. In order to address these issues, there has been much effort towards alternative electrodes, as reported in the literature. Graphene, carbon nanotubes (CNTs), and Ag nanowires have been proposed as alternatives to ITO. Graphene has outstanding optical properties, but a limited sheet resistance of 30 ohm square. The CNT networks also exhibit high sheet resistance and in addition, are less stable under ambient conditions. Ag nanowire networks show relatively superior performance in terms of transmittance and sheet resistance. But like any other network produced from pre-synthesized nanowires (tubes), they suffer from contact resistance at innumerable crossbar junctions and high roughness. Further, the redundant wires/tubes in the network can short the OSCs, which restricts its use in roll-to-roll fabrication. Often, they require an extra treatment, such as mechanical pressing, thermal treatment or poly(3,4-ethylenedioxythiophene) poly(styrenesulfonate) (PEDOT:PSS) coating to improve the performance.

Metal grids offer attractive alternatives to the above TCEs. Indeed being free of junctions, they exhibit high performance in terms of transmittance and sheet resistance, and have been successfully used in optoelectronic devices including OSCs. Typically, they are produced by patterning using lithographic techniques such as photolithography, soft lithography, phase shift lithography and nanoinprint lithography. A technologically relevant and simple alternative is the direct printing of grids using silver nanoparticle inks either by ink-jet printing or laser printing or flexographic and thermal imprinting. These recipes for Ag grids result in relatively large feature sizes. Such printed patterns are often used as current collecting grids in diverse applications.

Recently, metal meshes have been fabricated based on cracked TiO₂ templates and their application in touch screens has been shown. Some of us have shown, very recently, selective deposition of Cu by electroplating in the cracked regions of a polymer template to produce Cu mesh based TCEs. These cracked template methods are highly scalable but need to be tested for their applicability and device integration in thin film organic devices such as OSCs, OFETs, etc. One of the basic challenges is to obtain high light transmission maintaining low sheet resistance for such TCEs. Additionally, in thin film devices, the uniformity and connectivity of such meshes are very critical for the reproducibility of such devices.

In this study, we have explored the feasibility of cracking as a tool for the preparation of such metal meshes from inexpensive...
polymer templates at room temperature and integrating them as TCEs in bulk heterojunction OSCs. Specifically, using a seamless Ag network in the form of a mesh as a replacement for ITO electrodes, several OSCs having an inverted geometry have been made, which exhibited performance comparable to those produced using ITO. We like to note that this work emphasizes the suitability and reproducibility of such an ITO-free TCE in OSCs and not specifically the optimization of efficiency of any kind of device.

The process flow for templating is shown schematically in Fig. 1. First, a crack layer is produced by drying an acrylic based colloidal dispersion on a glass substrate wherein highly interconnected cracks are spontaneously obtained. These U-shaped grooves are complete cracks down to the substrate to be distinguished from incomplete cracks.34 Using the cracked template, the metal (Ag, 55 nm) is deposited by vacuum evaporation and subsequently, the template is washed away with chloroform.

As shown in Fig. 2a, the Ag mesostructures on glass appear to be well interconnected throughout the network. The metal fill factor is estimated to be ~20% with a structural width of ~2 μm and an average cell size (spacing between the Ag structures) of 20 to 60 μm. The optical profilometric image (1.2 × 0.8 mm²) in Fig. 2b not only reveals the connectivity of the Ag network over a large area but also shows its seamless nature. The surface roughness of the network is estimated to be ~5 nm while the peak-to-valley roughness, which corresponds to the network thickness, is 55 nm. The SEM image in Fig. 2c shows a junction where the network surface continues to be smooth and the junction itself is seamless unlike crossbar junctions commonly seen in network TCEs made from pre-synthesized Ag nanowires.21 Accordingly, the sheet resistance was found to be ~100 Ω·sq⁻¹, which is rather low considering the thickness of only 55 nm. The transmittance of the Ag network was ~86% at 550 nm (see Fig. 2d) and the overall transmittance is comparable to that exhibited by ITO but, importantly, extends down to the UV region (see the photograph in the inset). ITO, on the other hand, is a good UV absorber.

In the next step of solar cell fabrication, the ZnO barrier layer was brought in by decomposing a zinc acetate film at 150 °C in air (see ESI† for experimental details).35 For a proposed thickness of 45 nm of ZnO, the obtained layer was non-uniform and discontinuous (Fig. 3a) as evident from the dark and grey regions, the latter corresponding to the ZnO covered network. Beiley et al. described previously the fabrication of a Ag nanowire–ZnO nanoparticle composite to obtain a semi-transparent top electrode and achieved a good power conversion efficiency (PCE) of 4.3% in PBDTTTPD/PC70BM devices.36 Based on this fact, we increased the thickness of the ZnO layer to 95 nm, 135 nm and 230 nm. We observed an increasing degree of covering of the metal network with the increasing thickness of ZnO. For example, in the SEM image of the 135 nm ZnO layer shown in Fig. 3b, the ZnO film is seen to be uniformly submerging the entire Ag network. This is found to be the optimal ZnO thickness required to submerge the 55 nm thick Ag network so as to have reproducible devices without shorting.

Four bottom-illuminated inverted photovoltaic cells (5 devices in each) consisting of poly-3-hexylthiophene (P3HT) and phenyl-C61-butyric acid methyl ester (PCBM) were fabricated on a glass substrate, as shown schematically in Fig. 4a using a Ag network derived TCE. The bar graphs of solar cell parameters (Voc, Jsc, FF and PCE) for all four cells with varying thicknesses of the ZnO barrier layer are shown in Fig. 4b. In cell 1, all five devices with a 45 nm ZnO layer were defective due to shorting. For cell 2 with a 95 nm ZnO layer, only two devices were working with moderate efficiencies. On the other hand, for cells 3 and 4 with 135 and
230 nm ZnO barrier layer thicknesses, respectively, all five devices were found to be functioning. Significantly, the five devices with a 135 nm ZnO layer (cell 3), showed uniform performance with an average efficiency of 2.26 ± 0.05%, while those with a 230 nm ZnO layer exhibited some variations in performance with lower efficiency (1.34 ± 0.43%, see Fig. 4b).

The decrease in the cell efficiency for higher ZnO thicknesses can be attributed to higher series resistance of the cell leading to lower current density and fill factor values (see Fig. 4b). Indeed, the variations in solar cell parameters among the five devices exhibit a similar trend. The J–V characteristics of a typical example since the work function is favorable for P3HT–PCBM solar cells having an inverted geometry. However, it can be clearly understood from the differences in transmission of the respective electrodes in the UV region (Fig. 2d). The same information can be inferred by comparing the absorption spectra of the two solar cells (ESI, Fig. S3) with their EQE spectra.

The method developed in this study for the TCE and associated OSC fabrication has several merits. While the present study has focused on only one type of metallic network, its scope of application can be easily extended to other thin layer devices by varying the template thickness and other parameters in the initial stages of crack template formation. Thus, it is possible to obtain TCEs with different network thicknesses and connectivity and importantly with different metals. Here, Ag was used as a typical example since the work function is favorable for P3HT–PCBM solar cells having an inverted geometry. However, it can be replaced with other metals such as Cu, Al, and Pt depending on the need of application. The metal network based TCE used in the present study works as a current collecting grid at a tens of micrometer scale with a metal fill factor of 20%.

### Conclusions

In conclusion, we demonstrated the incorporation of a highly transparent and highly conducting Ag metallic network obtained using a cracked polymer template, in a thin film organic solar cell for the first time. The performance of this

### Table 1

Summary of the solar cell parameters corresponding to J–V characteristics shown in Fig. 5a. Note, that a Ag grid device has a 135 nm thick ZnO layer, whereas an ITO device has a ZnO layer of only 45 nm.

<table>
<thead>
<tr>
<th>TCE</th>
<th>(V_{oc}) (V)</th>
<th>(J_{sc}) (mA cm(^{-2}))</th>
<th>FF (%)</th>
<th>PCE (%)</th>
<th>(R_{sh}) ((\Omega) cm(^{-2}))</th>
<th>(R_s) ((\Omega) cm(^{-2})) (\times V_{oc})</th>
<th>(R_s) ((\Omega) cm(^{-2})) (\times P_{max})</th>
</tr>
</thead>
<tbody>
<tr>
<td>Ag grid</td>
<td>0.57</td>
<td>7.2</td>
<td>51.8</td>
<td>2.14</td>
<td>421</td>
<td>8.3</td>
<td>49.7</td>
</tr>
<tr>
<td>ITO</td>
<td>0.55</td>
<td>7.5</td>
<td>55.2</td>
<td>2.27</td>
<td>413</td>
<td>6.7</td>
<td>48.6</td>
</tr>
</tbody>
</table>
highly scalable metal network as a TCE is comparable to that of conventional ITO electrodes. This is a general approach to replace ITO in diverse thin film devices. The crack template approach is universal for any type of metal or substrate material.

Acknowledgements

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Notes and references